

XR5802HS GaN TRANSISTOR

Document Number: XR5802HS
Preliminary Datasheet V1.0

GaN 28V 20W, VHF to C band RF Power Transistor

Description

The XR5802HS itself is a 20W 28V GaN HEMT, implemented with unique match topology, enable extremely wideband applications with frequencies from HF to C band. It can support CW, and pulse or any modulation format.

To use paired XR5802HS with broadband circuit topology, it can deliver 30W CW at 32V within 0.3-6.2GHz as its typical ultrawide band application

XR5802HS



- Typical performance using XR5802HS*2 (on Innogration fixture with device soldered)

Vds = 32V, Vgs = -2.4V, Idq = 200mA Signal mode: CW

Freq(MHz)	Pin(dBm)	Pout(dBm)	Pout(W)	Ids(A)	Gain(dB)	Eff (%)	2nd (dBc)	3rd (dBc)
300	31.00	45.20	33.1	1.68	14.2	61.6	-10.4	-13.1
500	30.30	46.05	40.3	1.87	15.8	67.3	-14.3	-14.8
1000	34.40	46.60	45.7	3.02	12.2	47.3	-22.9	-19.3
1500	35.00	45.10	32.4	3.36	10.1	30.1	-30.6	-17.7
2000	38.90	46.10	40.7	3.76	7.2	33.9	-26.8	-13.5
2500	39.00	47.05	50.7	3.63	8.1	43.6	-23.0	-22.1
3000	39.00	45.00	31.6	3.58	6.0	27.6	-29.4	-27.5
3500	39.00	45.70	37.2	3.29	6.7	35.3	/	/
4000	39.00	46.15	41.2	4.15	7.2	31.0	/	/
4500	39.00	46.05	40.3	4.03	7.1	31.2	/	/
5000	39.00	47.54	56.8	3.70	8.5	47.9	/	/
5500	39.00	45.05	32.0	3.89	6.1	25.7	/	/
6000	39.00	46.65	46.2	3.99	7.7	36.2	/	/
6100	37.80	46.25	42.2	3.79	8.5	34.8	/	/
6200	36.20	46.10	40.7	3.68	9.9	34.6	/	/
6400	36.60	45.03	31.8	3.56	8.4	28.0	/	/

Applications and Features

- Suitable for wireless communication infrastructure, wideband amplifier, EMC testing, ISM etc.
- High Efficiency and Linear Gain Operations
- Thermally Enhanced Industry Standard Package
- High Reliability Metallization Process
- Excellent thermal Stability and Excellent Ruggedness
- Compliant to Restriction of Hazardous Substances (RoHS) Directive 2002/95/EC

Important Note: Proper Biasing Sequence for GaN HEMT Transistors

Turning the device ON

- Set VGS to the pinch-off (VP) voltage, typically -5 V
- Turn on VDS to nominal supply voltage (28V)
- Increase VGS until IDS current is attained
- Apply RF input power to desired level

Turning the device OFF

- Turn RF power off
- Reduce VGS down to VP, typically -5 V
- Reduce VDS down to 0 V
- Turn off VGS

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Table 1. Maximum Ratings (Not simultaneous, TC = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain--Source Voltage	V_{DS}	150	Vdc
Gate--Source Voltage	V_{GS}	-10,+2	Vdc
Operating Voltage	V_{DD}	36	Vdc
Maximum Forward Gate Current	I_{gmax}	8	mA
Storage Temperature Range	T_{stg}	-65 to +150	°C
Case Operating Temperature	T_c	+150	°C
Operating Junction Temperature(See note 1)	T_J	+225	°C

1. Continuous operation at maximum junction temperature will affect MTTF
2. Bias Conditions should also satisfy the following expression: $P_{diss} < (T_J - T_c) / R_{JC}$ and $T_c = T_{case}$

Table 2. Thermal Characteristics

Characteristic	Symbol	Value	Unit
Thermal Resistance, Junction to Case $T_c = 85^\circ\text{C}$, $T_J = 200^\circ\text{C}$, FEA	$R_{\theta JC-DC}$	4.2	°C/W

Table 3. Electrical Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise noted)

DC Characteristics

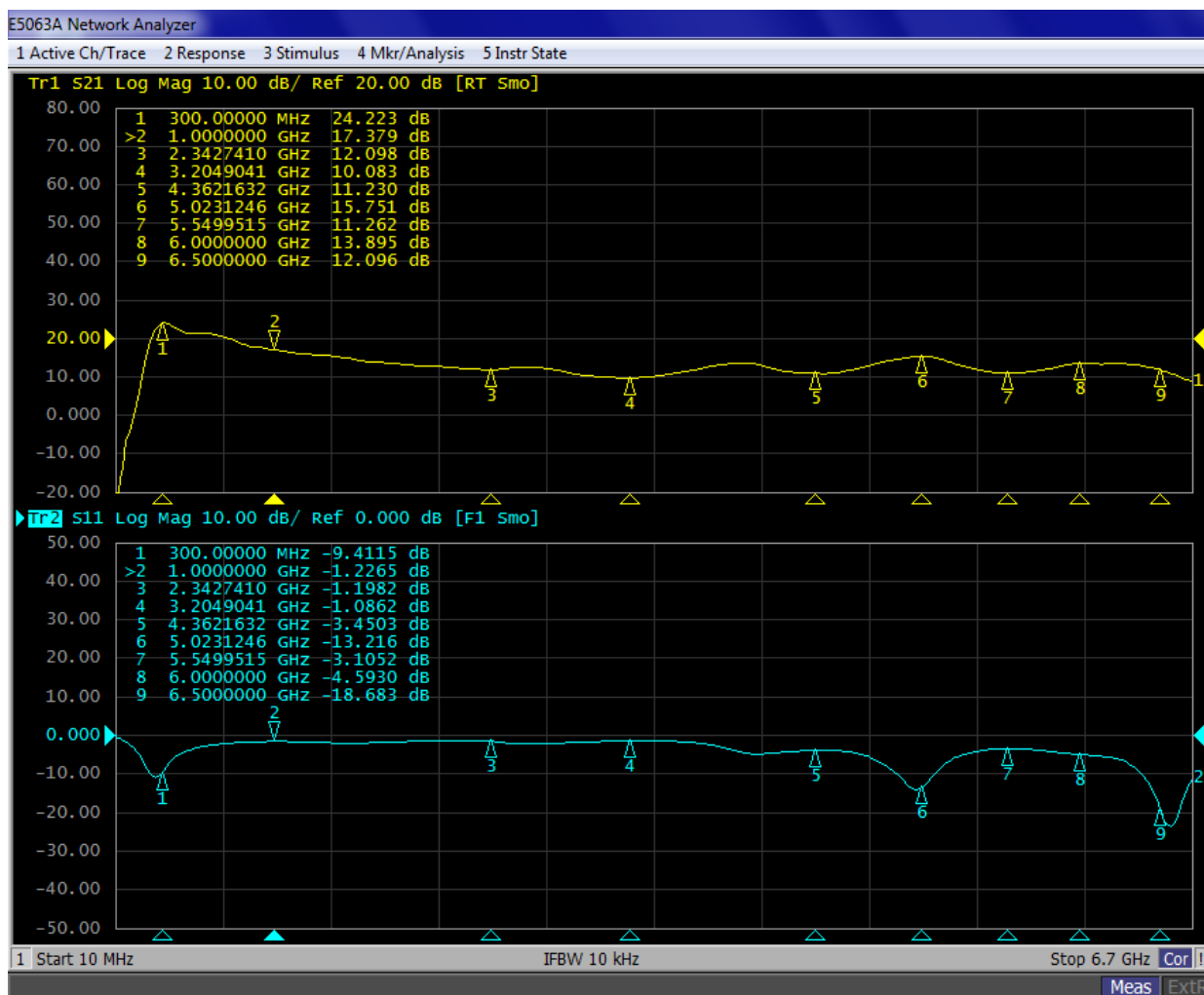
Characteristic	Conditions	Symbol	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	$V_{GS} = -8\text{V}$; $I_{DS} = 5\text{mA}$	V_{DS}	150			V
Gate Threshold Voltage	$V_{DS} = 28\text{V}$, $I_D = 5\text{mA}$	$V_{GS(th)}$		-2.5		V
Gate Quiescent Voltage	$V_{DS} = 28\text{V}$, $I_{DS} = 100\text{mA}$, Measured in Functional Test	$V_{GS(Q)}$		-2.4		V

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0.3-6GHz with XR5802HS*2

Figure 2. Network Analyzer S11/S21 output



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Package Outline

Earless ceramic package; 4 leads

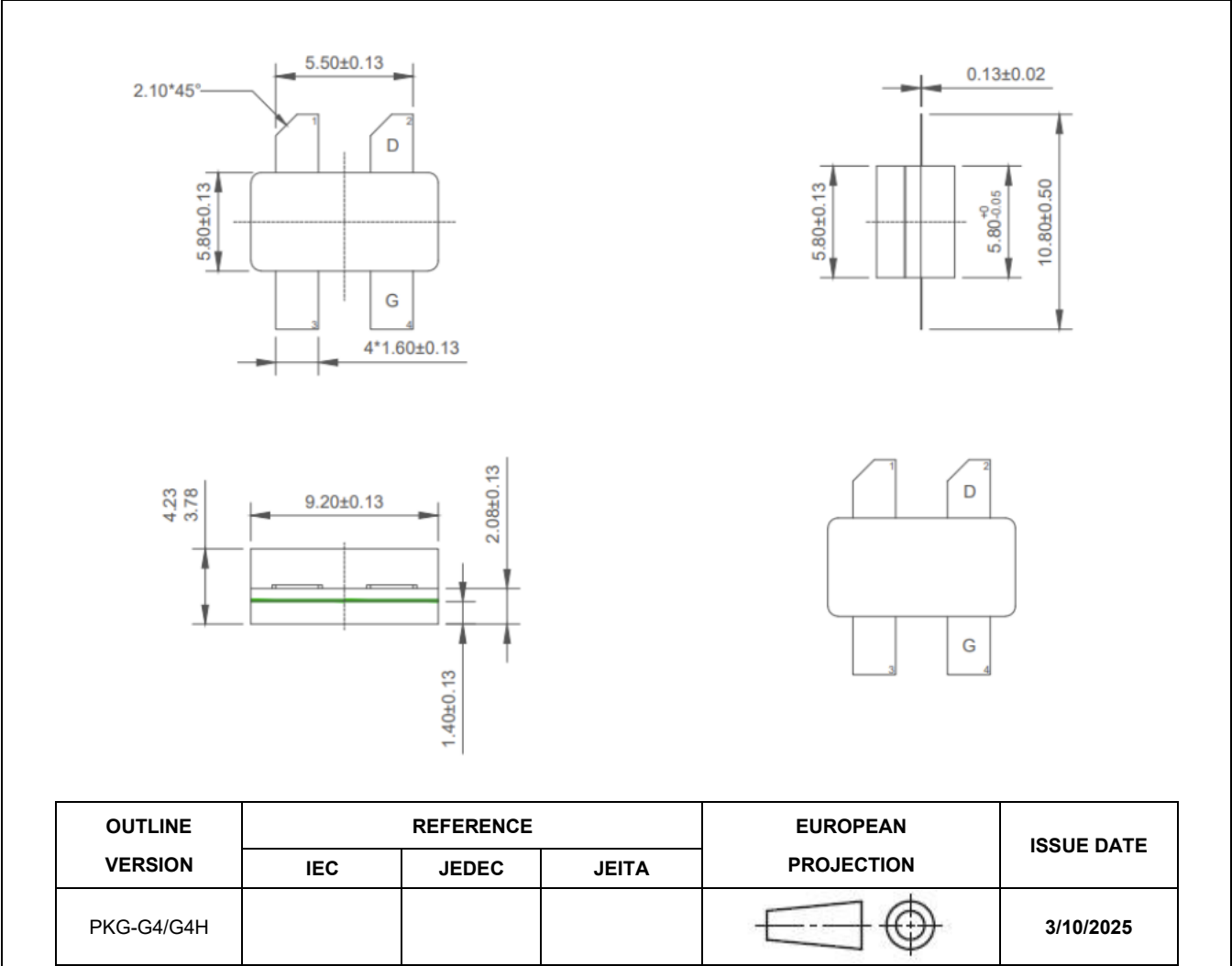


Figure 1. Package Outline PKG-G4/G4H

Revision history

Table 5. Document revision history

Date	Revision	Datasheet Status
2025/11/24	V1.0	Preliminary datasheet creation

Application data based on RXT-25-40

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